
**Microbeam analysis — Electron
backscatter diffraction — Measurement
of average grain size**

*Analyse par microfaisceaux — Diffraction d'électrons rétrodiffusés —
Mesurage de la taille moyenne des grains*





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Case postale 56 • CH-1211 Geneva 20
Tel. + 41 22 749 01 11
Fax + 41 22 749 09 47
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